

Notice of References Cited	Application/Control No. 09/801,621	Applicant(s)/Patent Under Reexamination WIJNSTRA, JAN GERBEN	
	Examiner Haresh Patel	Art Unit 2154	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0058277	03-2003	BOWMAN-AMUAH, MICHEL K.	345/765
*	B	US-6,961,687	11-2005	Myers et al.	703/6
*	C	US-6,898,791	05-2005	Chandy et al.	719/314
*	D	US-6,532,465	03-2003	Hartley et al.	707/10
*	E	US-5,710,896	01-1998	Seidl, Robert	715/744
*	F	US-6,631,122	10-2003	Arunachalam et al.	370/332
*	G	US-6,496,850	12-2002	Bowman-Amuah, Michel K.	709/203
*	H	US-6,477,665	11-2002	Bowman-Amuah, Michel K.	714/39
*	I	US-6,477,580	11-2002	Bowman-Amuah, Michel K.	709/231
*	J	US-6,442,748	08-2002	Bowman-Amuah, Michel K.	717/108
*	K	US-6,438,594	08-2002	Bowman-Amuah, Michel K.	709/225
*	L	US-6,339,832	01-2002	Bowman-Amuah, Michel K.	714/35
*	M	US-6,529,909	03-2003	Bowman-Amuah, Michel K.	707/10

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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